



A Millimeter-Wave Fully Differential Transformer-based Passive Reflective-Type Phase Shifter

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- **Motivation**
- **Fundamentals of reflective-type phase shifter**
- **Our design and innovations**
- **Measurement**
- **Conclusion**



- **Why passive phase shifters (PS)?**
 - Zero DC power consumption
 - Excellent linearity(Essential in large-scaled and power-constrained phased array systems)
- **Why passive reflective-type phase shifter (RTPS) ?**
 - Continuous and dense phase shift (switch-filter and high/low-pass PS)
 - Moderate size (switched-line PS and traveling-wave PS)
 - Cascadable architecture ($90^\circ + 90^\circ = 180^\circ$)
- **Challenges of mm-Wave RTPS nowadays:**
 - Phase shift range $< 360^\circ$ ($90^\circ - 180^\circ$)
 - High loss if multi-section RTPS in cascade ($> 15\text{dB}$)
 - Figure-of-merit (FoM) $< 26^\circ/\text{dB}$

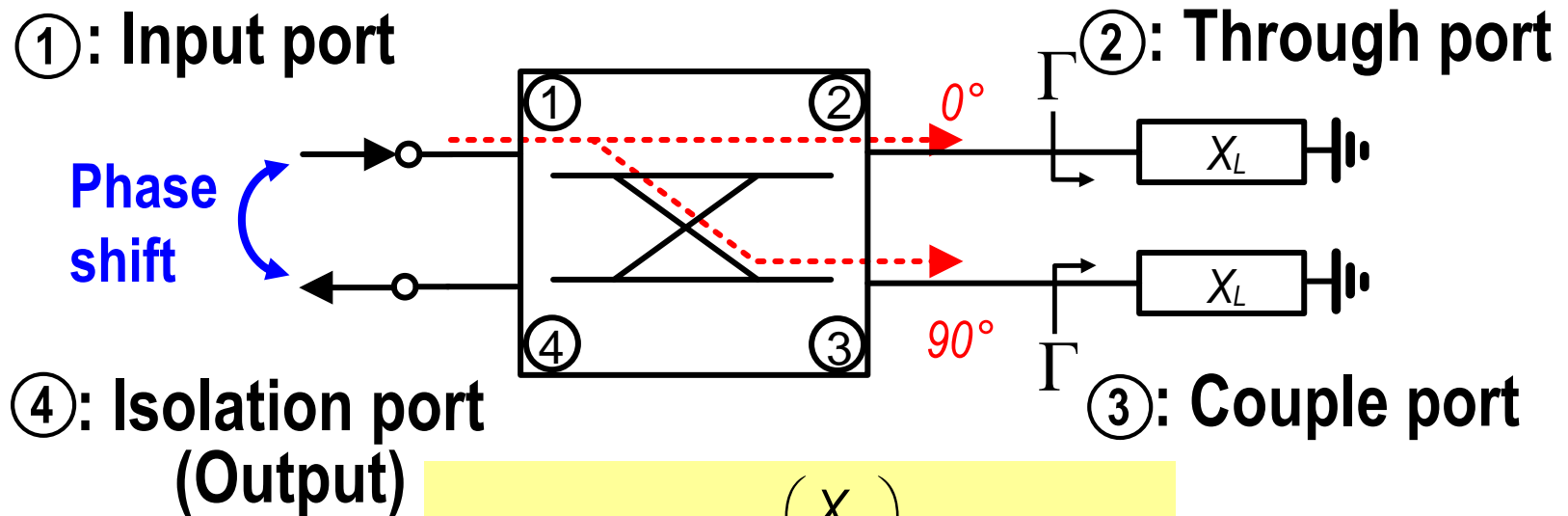
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- RTPS architecture:**

- One 90° coupler (Characteristic impedance= Z_0)
- Two identical reflective passive loads (X_L)

Total loss = 90° coupler loss + load loss



$$\theta = -90^\circ - 2 \tan^{-1} \left(\frac{X_L}{Z_0} \right) = -90^\circ - \angle \Gamma$$

Phase shift between I/O is made by reflection coefficient of loads

• RTPS architecture:

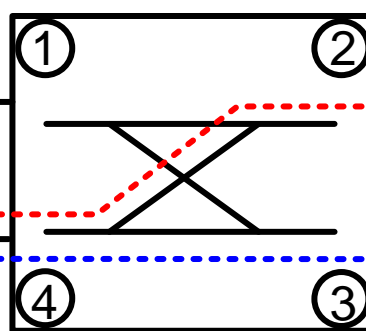
- One 90° coupler (Characteristic impedance= Z_0)
- Two identical reflective passive loads (X_L)

Total loss = 90° coupler loss + load loss

①: Input port

Phase shift

④: Isolation port
(Output)



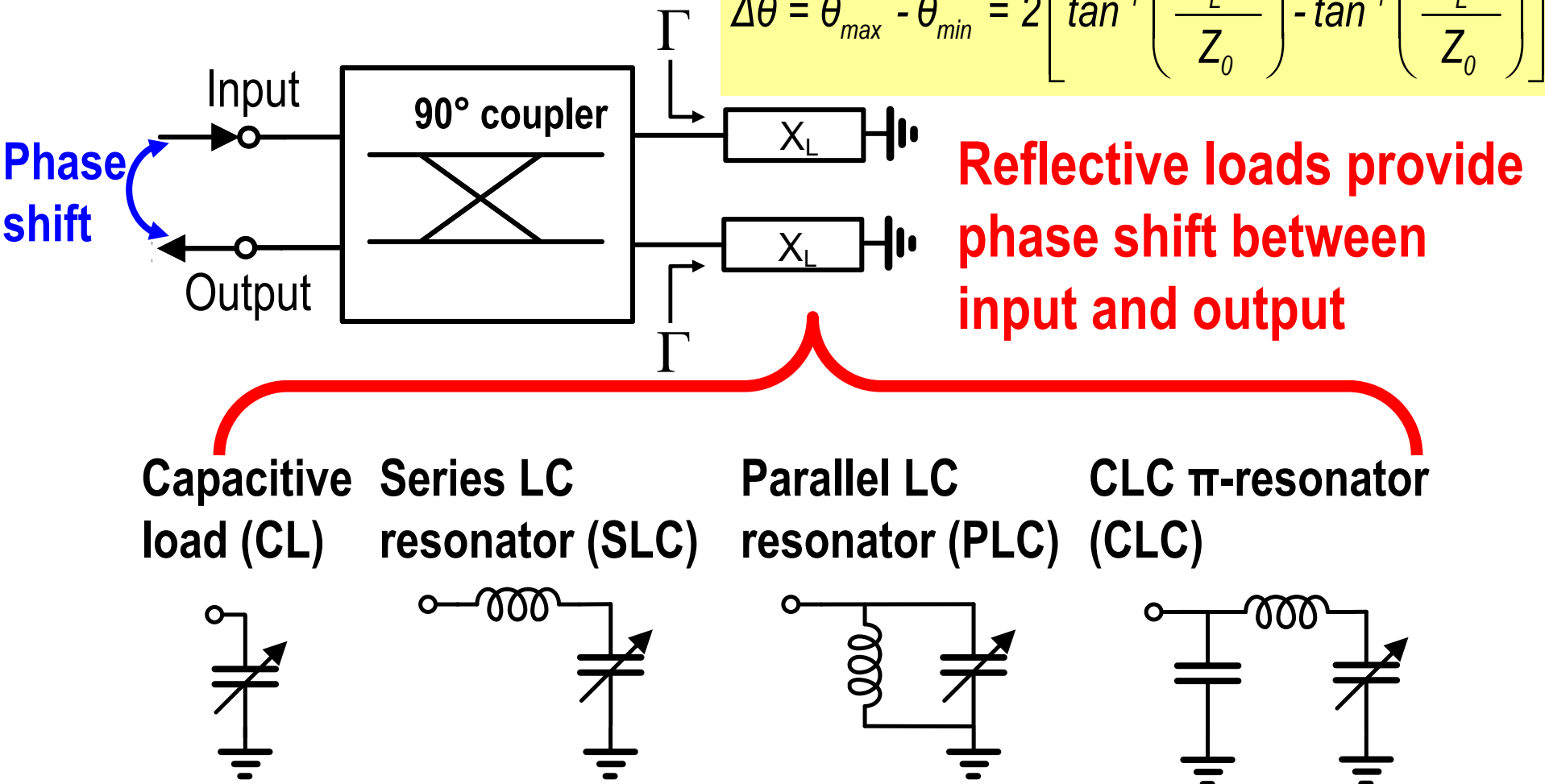
②: Through port

③: Couple port

$$\theta = -90^\circ - 2 \tan^{-1} \left(\frac{X_L}{Z_0} \right) = -90^\circ - \angle \Gamma$$

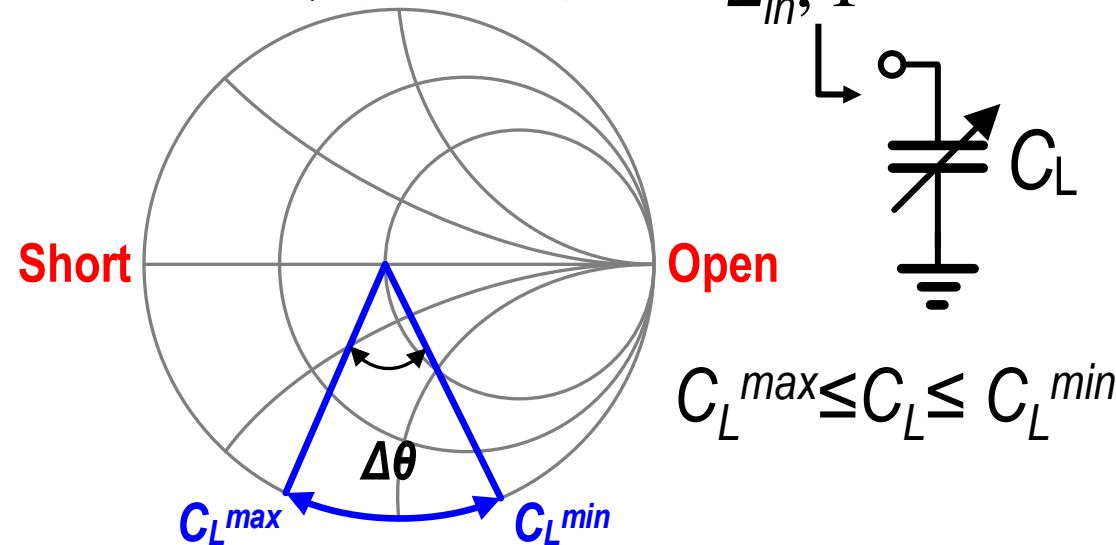
Phase shift between I/O is made by reflection coefficient of loads

- Reflective passive loads



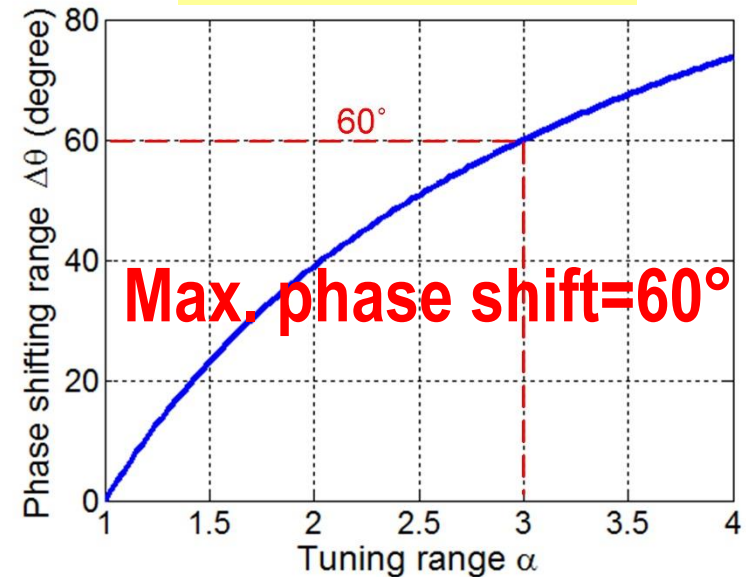
- Capacitive load (CL)

$$C_L^{min} = 1/(\sqrt{\alpha}Z_0\omega_0)$$



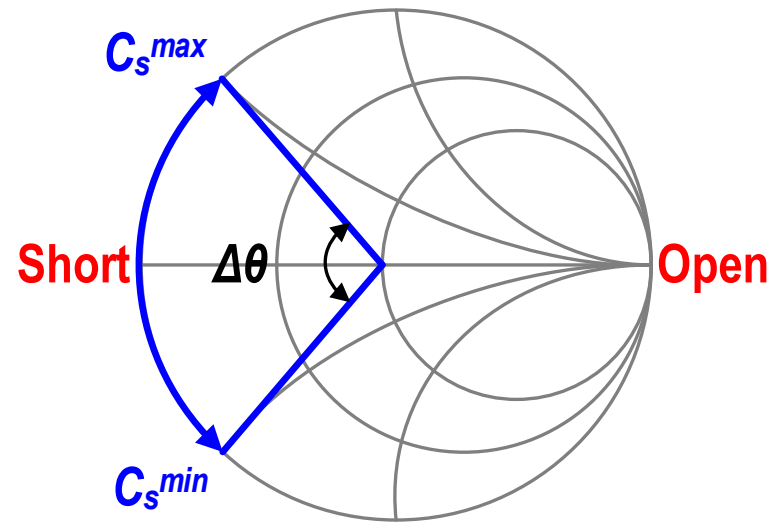
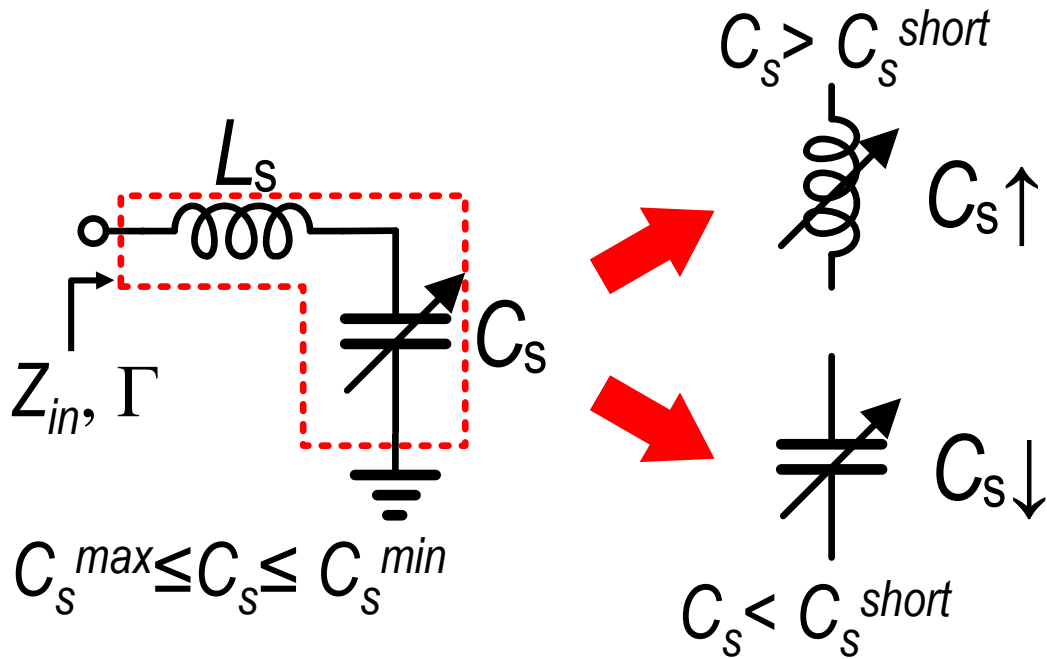
Assuming circuit is lossless

$$\Delta\theta_{max} = 2\tan^{-1}\left(\frac{\alpha-1}{2\sqrt{\alpha}}\right)$$



- Phase shift of CL RTPS strongly depends on tuning range ($\alpha = C_L^{max}/C_L^{min}$) of varactors. ($2 \leq \alpha \leq 4$)

- Series LC resonator load (SLC)

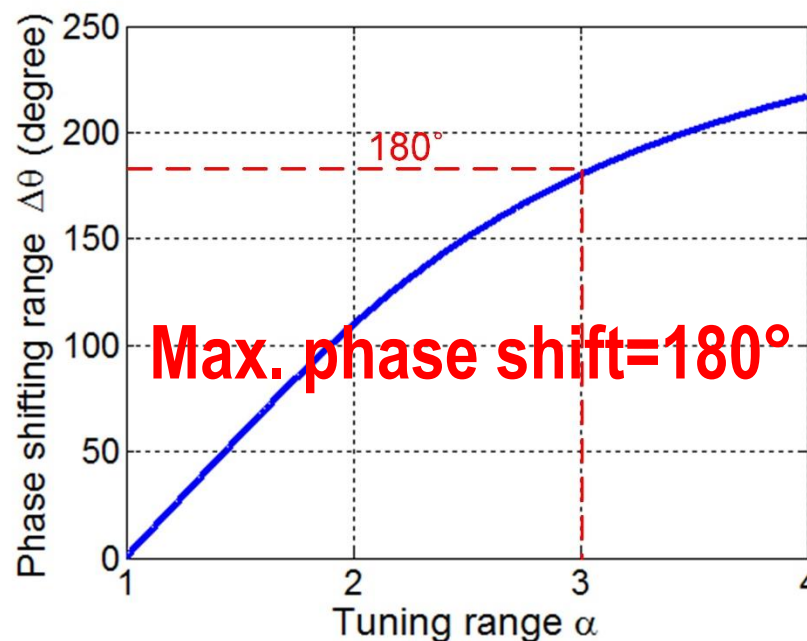
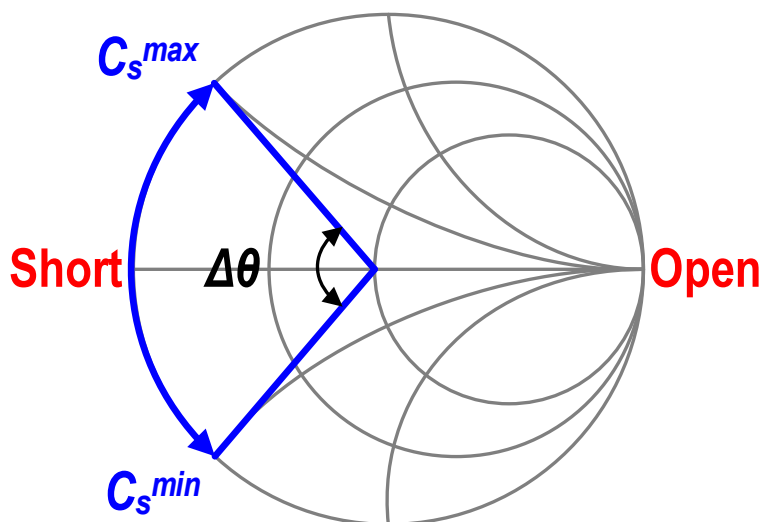


- L_s - C_s tank is inductive when C_s increases. ($C_s > C_s^{short}$)
- L_s - C_s tank is capacitive when C_s decreases. ($C_s < C_s^{short}$)

- Series LC resonator load (SLC)

$$\Delta\theta_{max} = 2\tan^{-1}\left(\frac{2}{\sqrt{\alpha}}\frac{\alpha-1}{\alpha-3}\right)$$

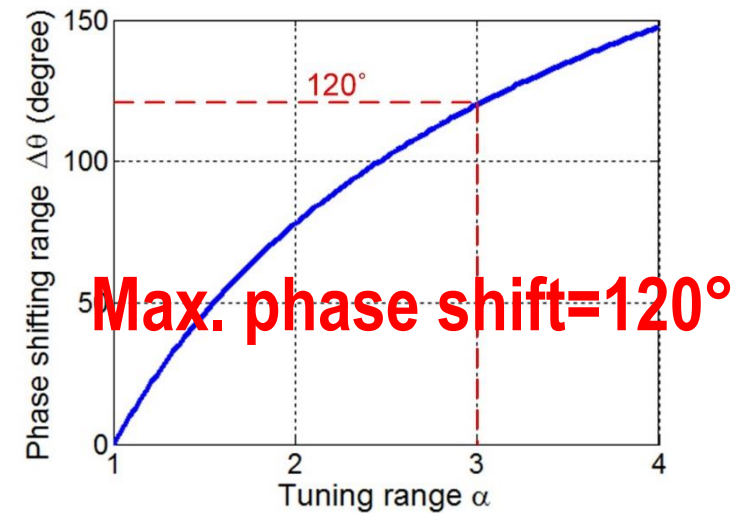
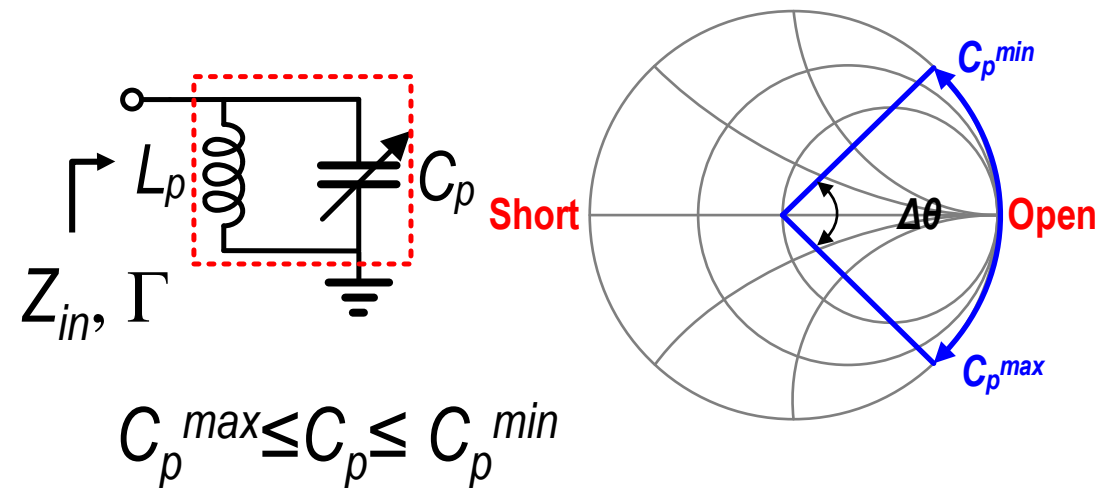
$$C_s^{min} = 1/(\sqrt{\alpha}Z_0\omega_0)$$



- Phase shift of SLC is wider than CL because SLC covers one resonance point.

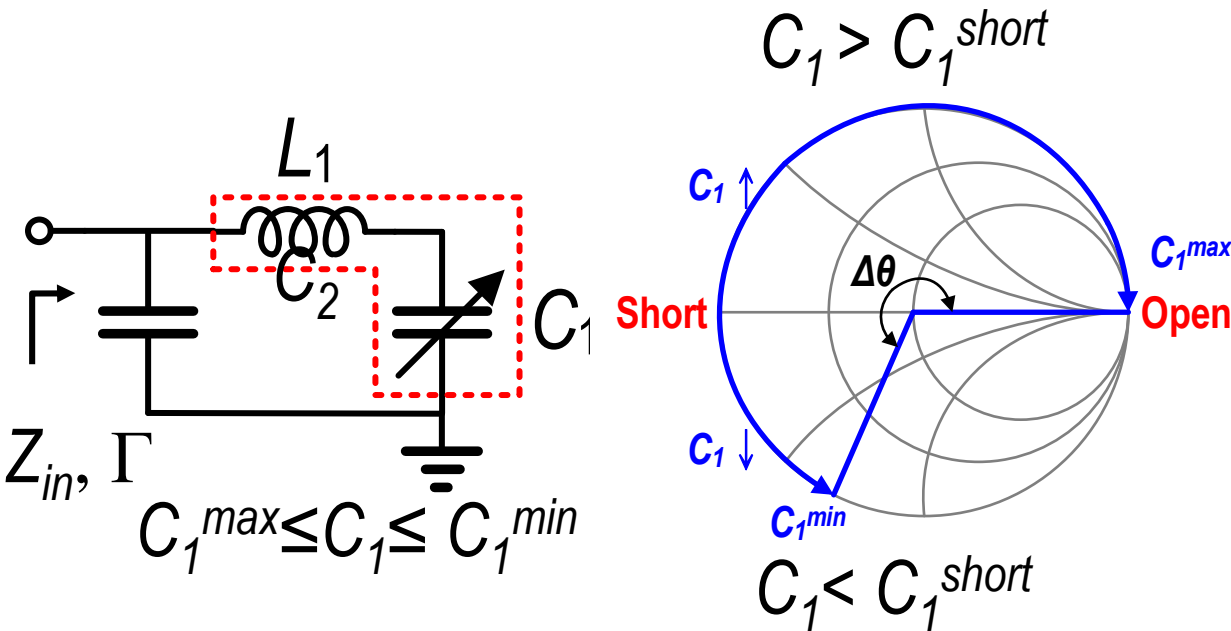
- Parallel LC resonator load (PLC)

$$C_p^{min} = 1/(\sqrt{\alpha}Z_0\omega_0)$$

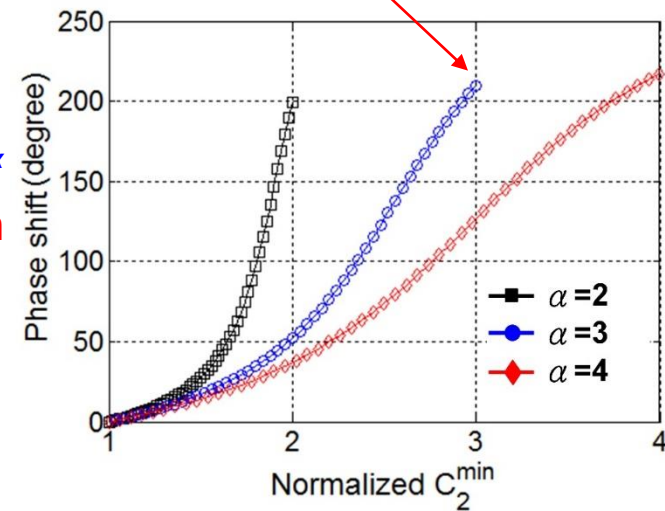


– Phase shift of PLC is wider than CL because PLC covers one resonance point.

CLC π -resonator load (CLC)



Max. phase shift = 210°



- L_1 - C_1 tank resonates at S.C $\rightarrow Z_{in} = 0$
- L_1 - C_1 tank is inductive when C_1 increases. ($C_1 > C_1^{short}$)
- L_1 - C_1 tank is capacitive when C_1 decreases. ($C_1 < C_1^{short}$)

- **Summary of reported reflective loads of RTPS**

Reflective load type	Resonance point	Maximum phase shift* (°)
Capacitive Load	0	60
Series LC resonator	1	180
Parallel LC resonator	1	120
CLC π resonator	2	210

Assuming the tunable capacitance $C^{min}=1/(\sqrt{a}Z_0\omega_0)$

More resonance points achieved, wider phase shift obtained

– How to increase phase shifting range?

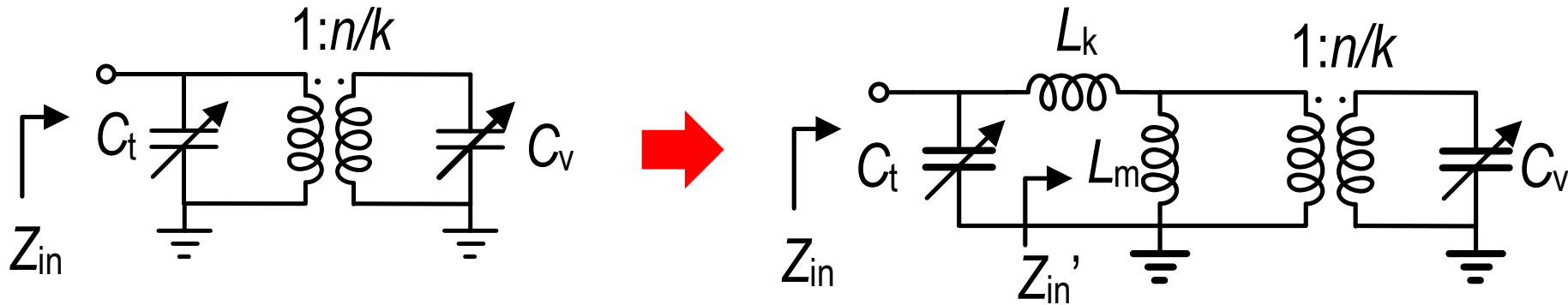
- 1) Enhancing tuning range of varactors → limited by process
- 2) Cascading RTPSs → loss also increasing
- 3) Multi-resonance reflective load → complexity ↑, loss ↑

*Tuning range=3

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Transformer-based multi-resonance load (single-end)



– Multi-resonance load:

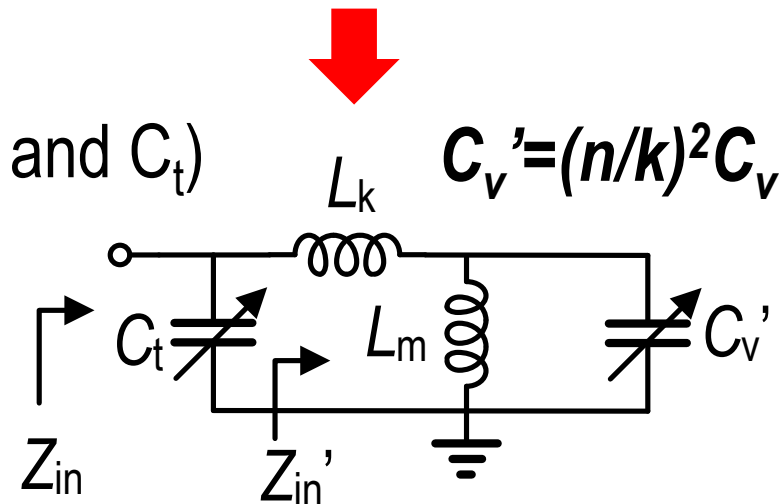
one transformer + two varactors (C_v and C_t)

– Leakage inductance: $L_k = (1 - k^2)L_t$

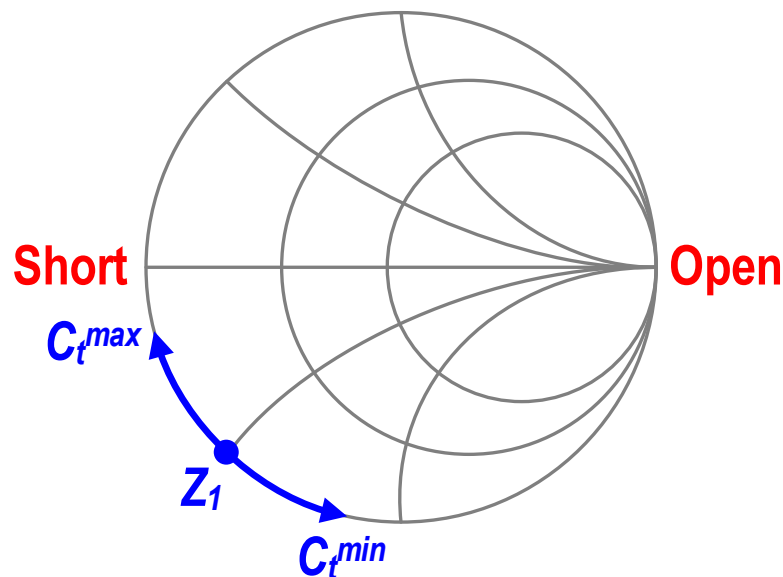
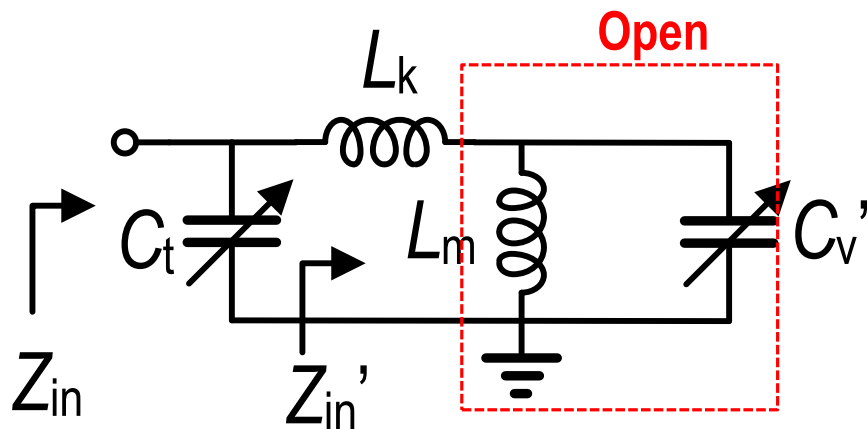
– Magnetizing inductance: $L_m = k^2 L_t$

– Magnetic coupling coefficient: k

– Self-inductances of primary side: L_t

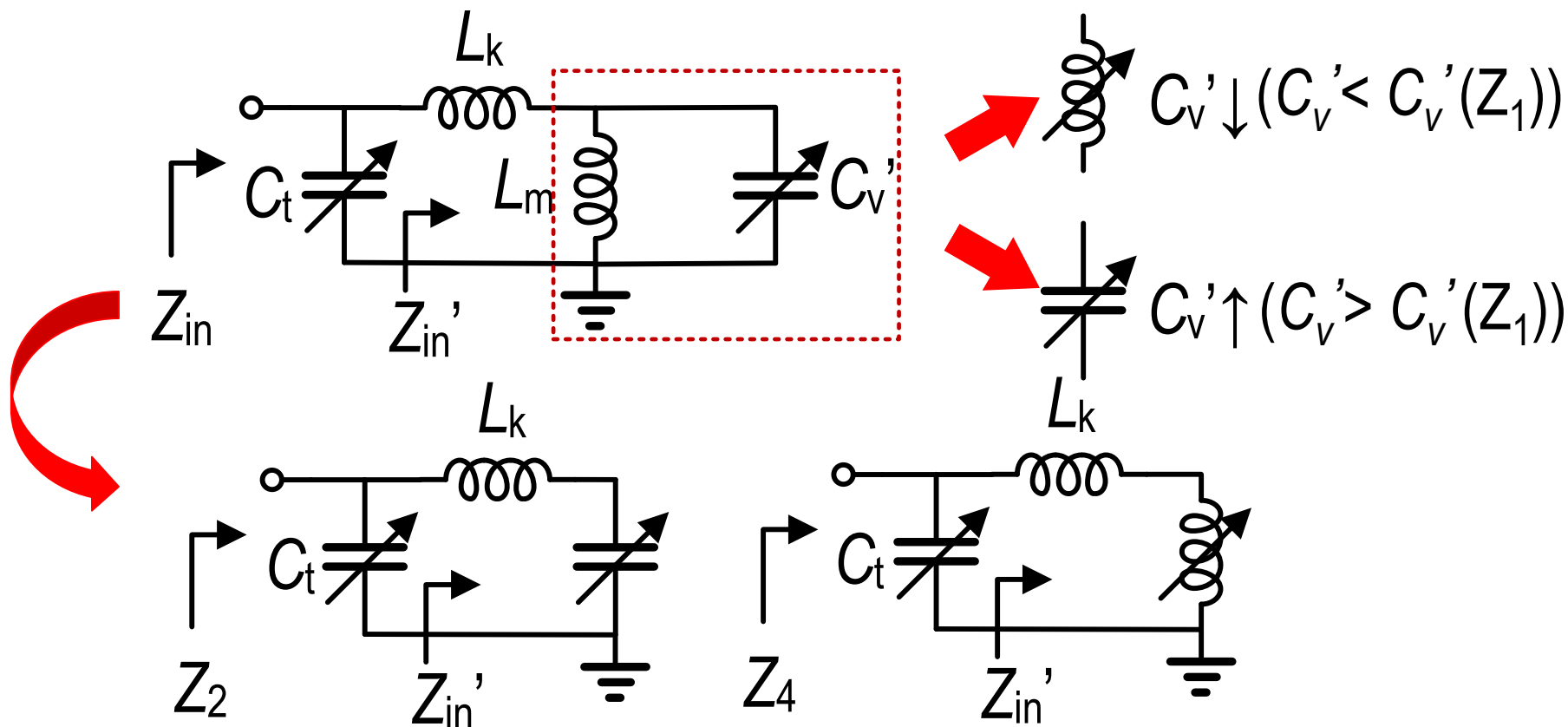


Transformer-based multi-resonance load (single-end)



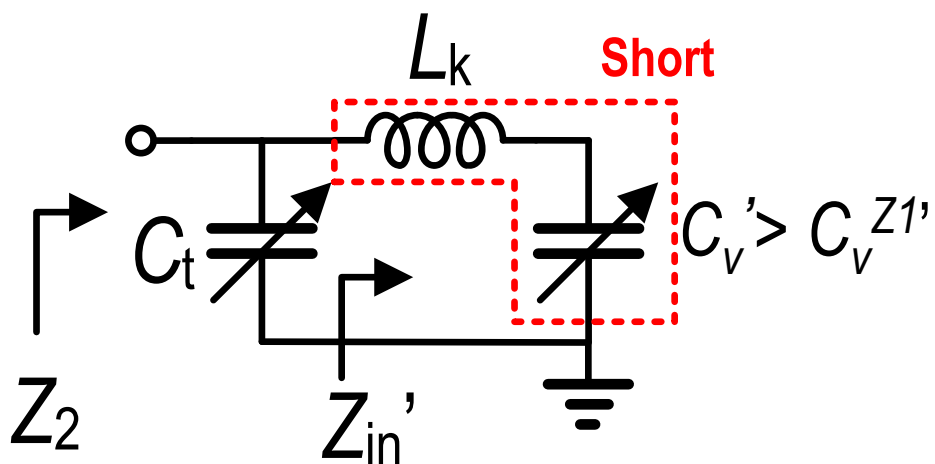
- Assume all components are lossless to simplify analysis.
- Tuning range: (in this analysis)
 $\alpha = C_t^{max}/C_t^{min} = C_t^{max}/C_t^{min}$
- $Lm-C_v'$ tank resonates at open
 $\rightarrow Z_{in}' = \infty$
- Input impedance is determined by $C_t \rightarrow Z_{in} = Z_1 = 1/j\omega_o C_t$

- Transformer-based multi-resonance load (single-end)



- L_m - C_v' tank shows inductive or capacitive behaviors when C_v' is away from the resonance point.

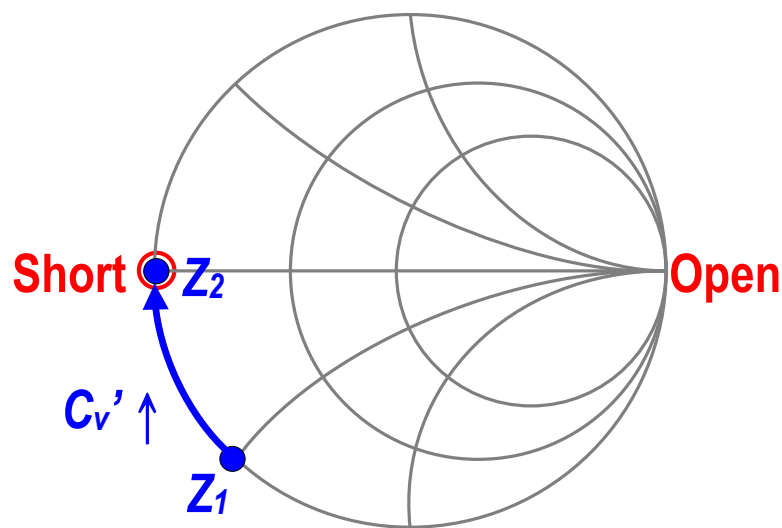
Transformer-based multi-resonance load (single-end)



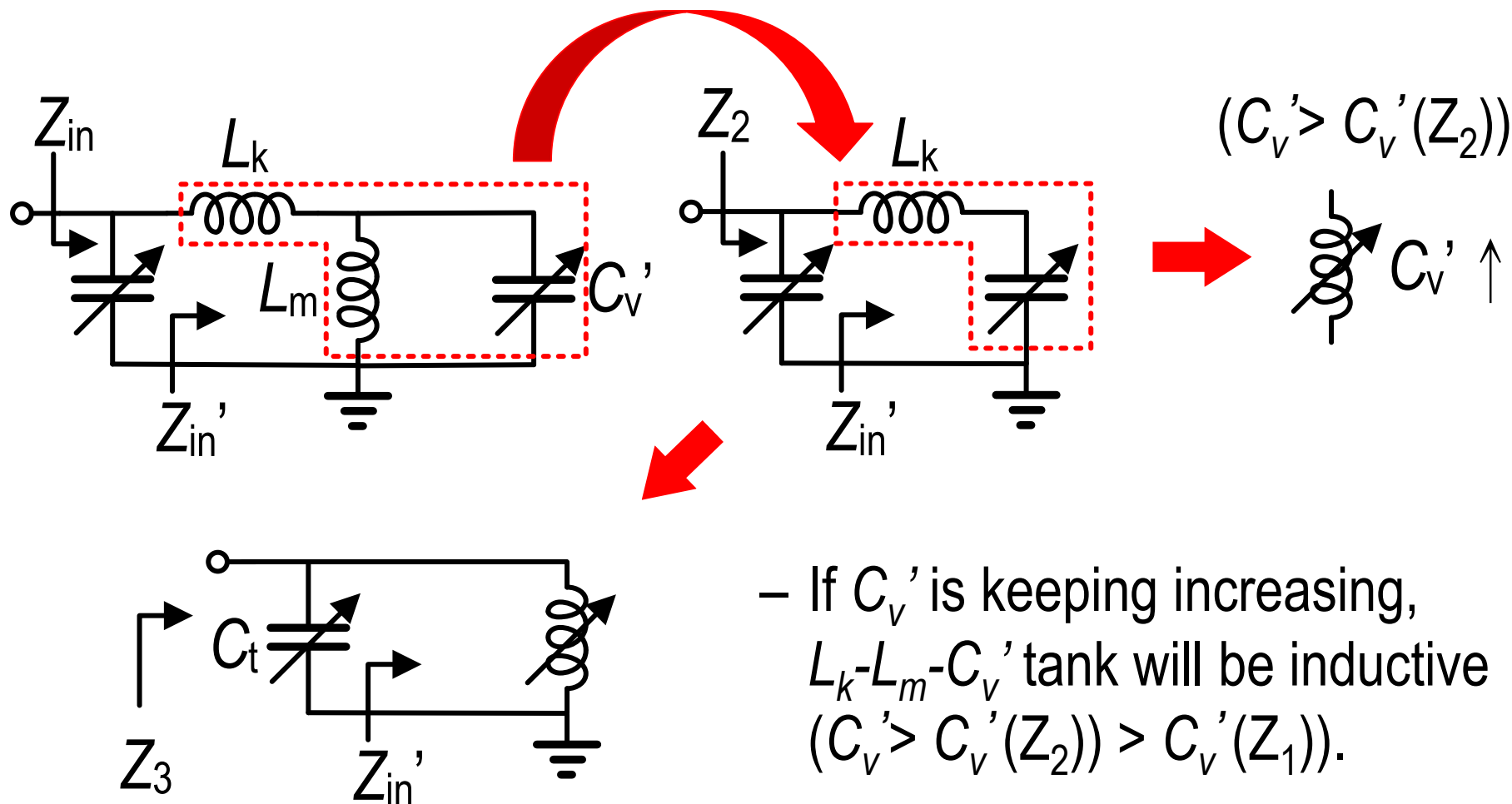
– L_m - C_v' tank is capacitive when C_v' increases ($C_v' > C_v'(Z_1)$).

– L_k - L_m - C_v' tank resonates at short $\rightarrow Z_{in}' = 0 \rightarrow Z_{in} = Z_2 = 0$.

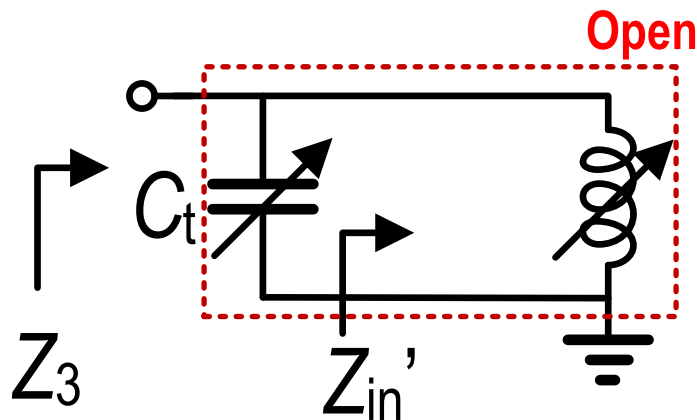
– 1st resonance point achieved (similar to SLC)



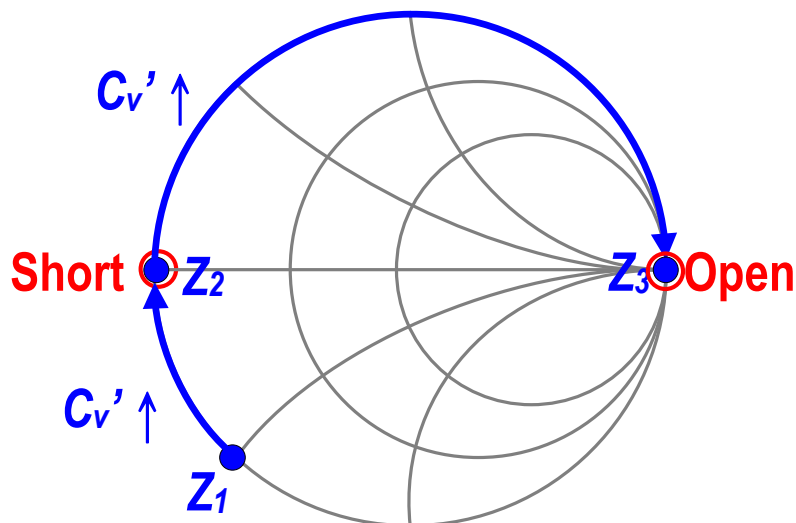
- Transformer-based multi-resonance load (single-end)



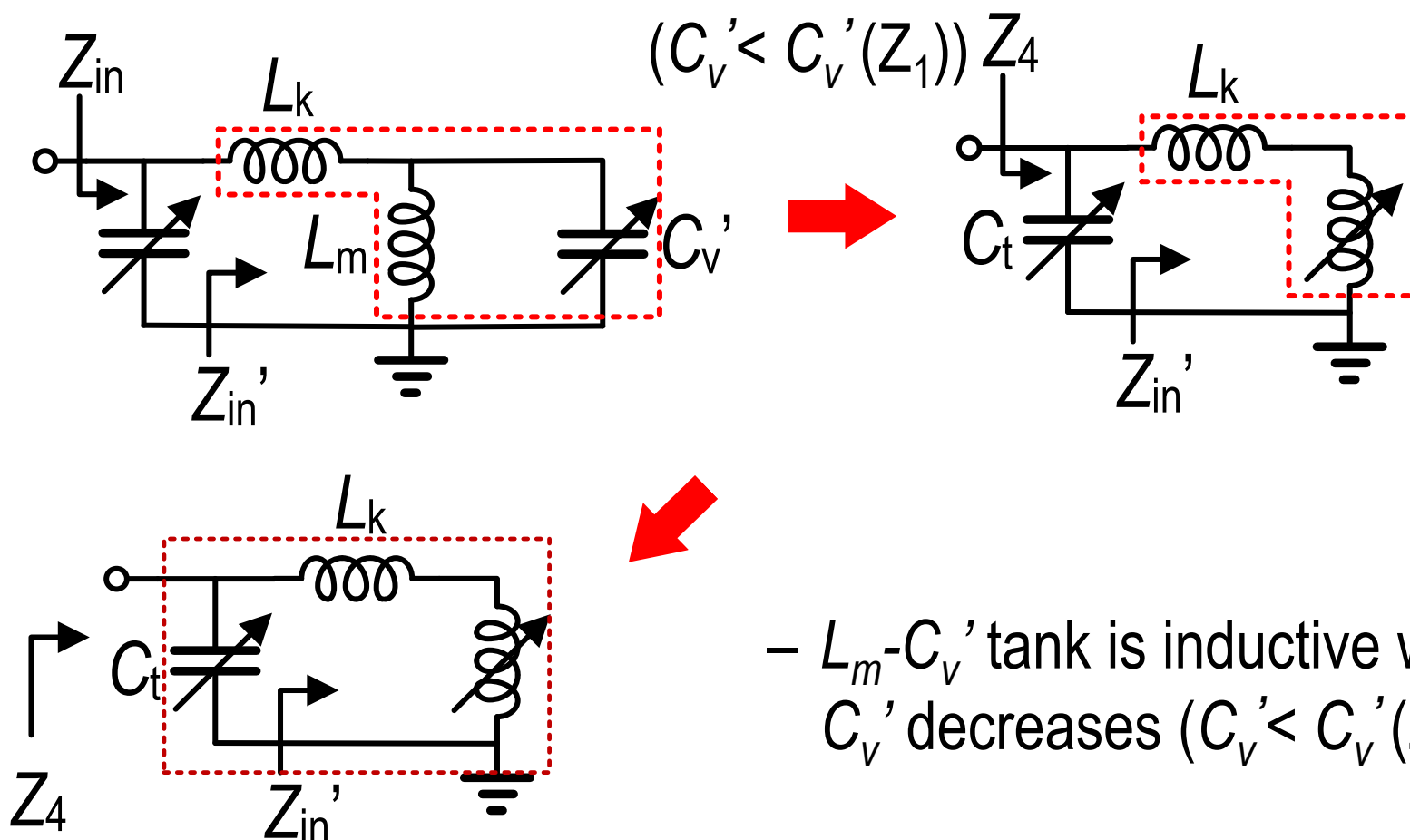
- Transformer-based multi-resonance load (single-end)



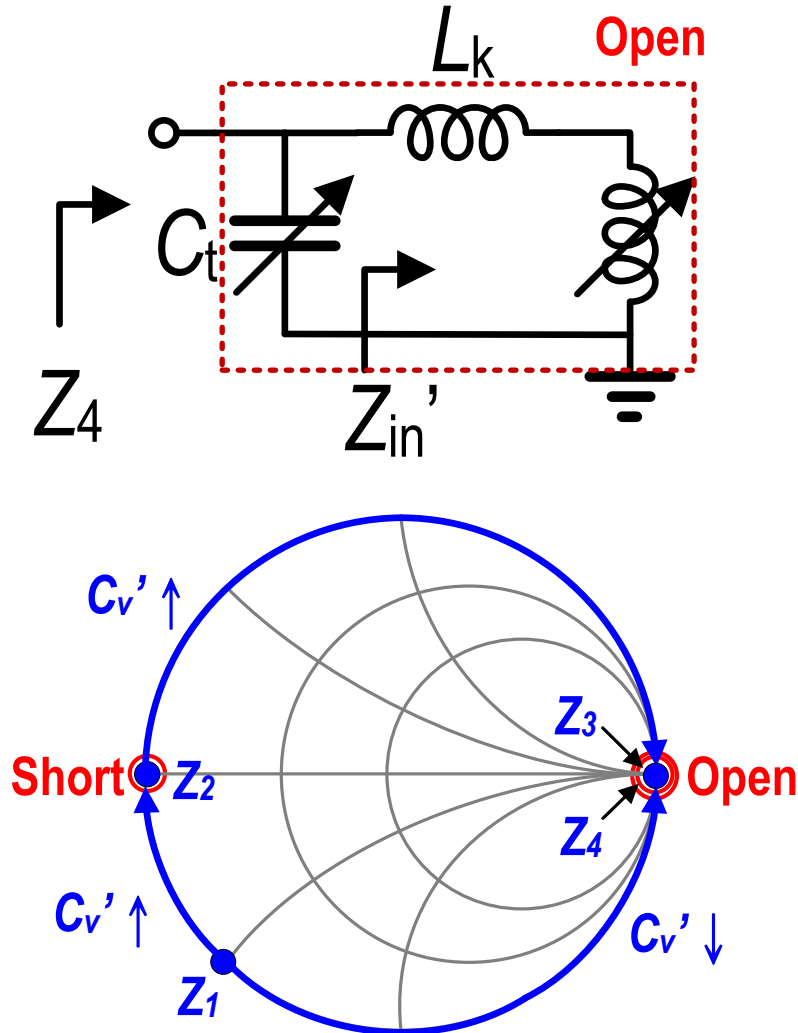
- L_k - L_m - C_v^{max} tank resonates with C_t^{max} at open $\rightarrow Z_{in}=Z_3=\infty$.
- 2nd resonance point achieved (similar to CLC).



- Transformer-based multi-resonance load (single-end)

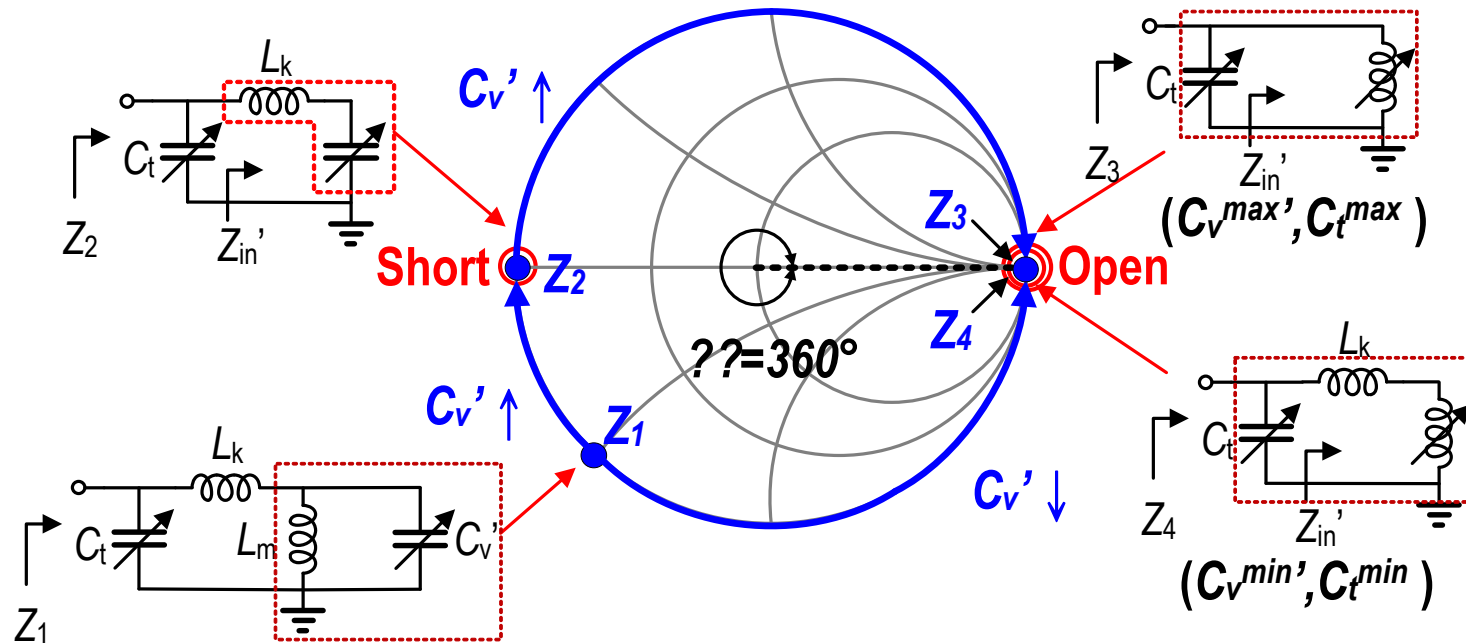


Transformer-based multi-resonance load (single-end)



- L_m - C_v' tank is inductive when C_v' decreases ($C_v' < C_v'(Z_1)$).
- L_k - L_m - C_v^{min} tank resonates with C_t^{min} at open $\rightarrow Z_{in} = Z_4 = \infty$.
- 3rd resonance point achieved (similar to PLC).

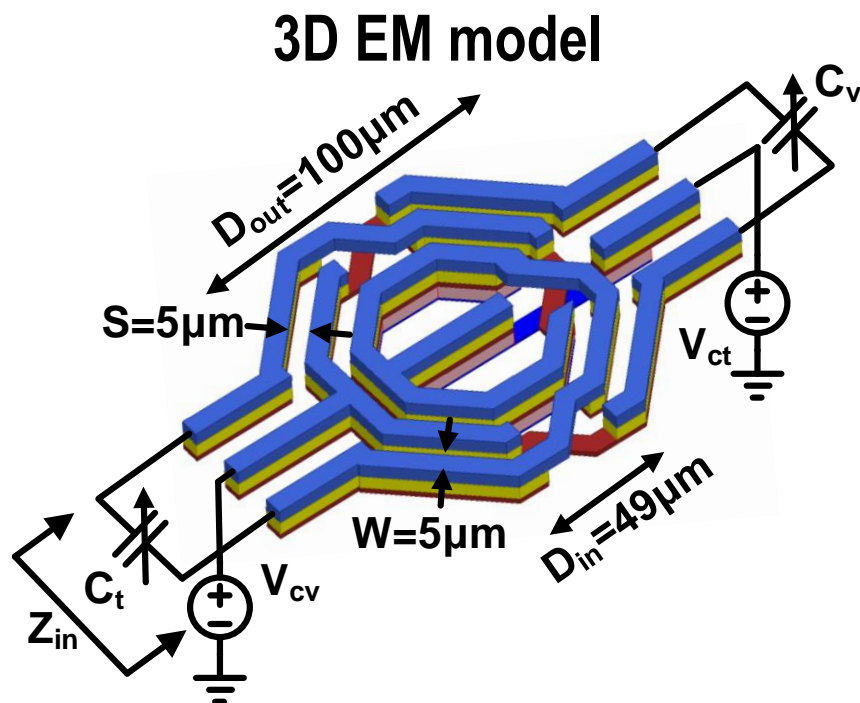
- Transformer-based multi-resonance load (single-end)



$$\frac{C_t^{\max}}{C_t^{\min}} = \alpha = \frac{(1 - k^2) + k^2 / (1 - \omega_0^2 n^2 L_t C_v^{\min})}{(1 - k^2) + k^2 / (1 - \omega_0^2 n^2 L_t \alpha C_v^{\min})}$$

Three resonance points made → ensure phase shift $\geq 360^\circ$

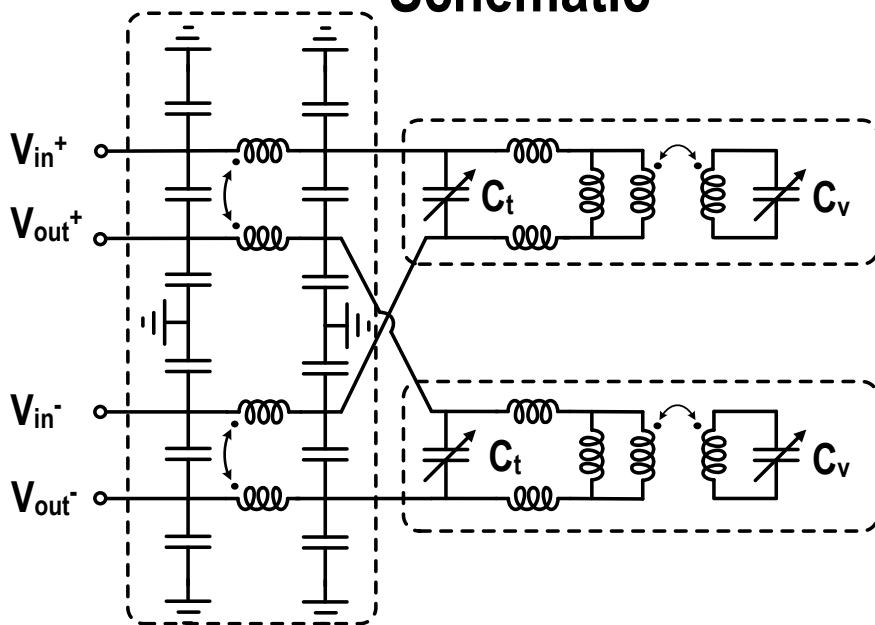
- Transformer-based multi-resonance reflective load



- 2-to-1 transformer with optimum $k=0.63$.
- 130nm BiCMOS
- $46\text{fF} \leq C_v \leq 125\text{fF}$
($-1\text{V} \leq V_{cv} \leq 0.45\text{V}$)
- $21\text{fF} \leq C_t \leq 57\text{fF}$
($-1\text{V} \leq V_{ct} \leq 0.45\text{V}$)

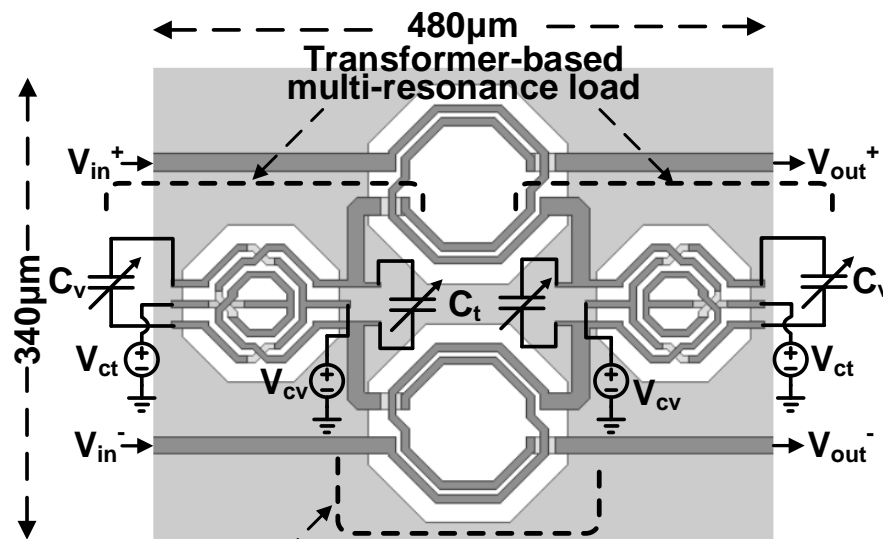
- Fully differential transformer-based RTPS

Schematic



Differential 90° coupler

3D EM model



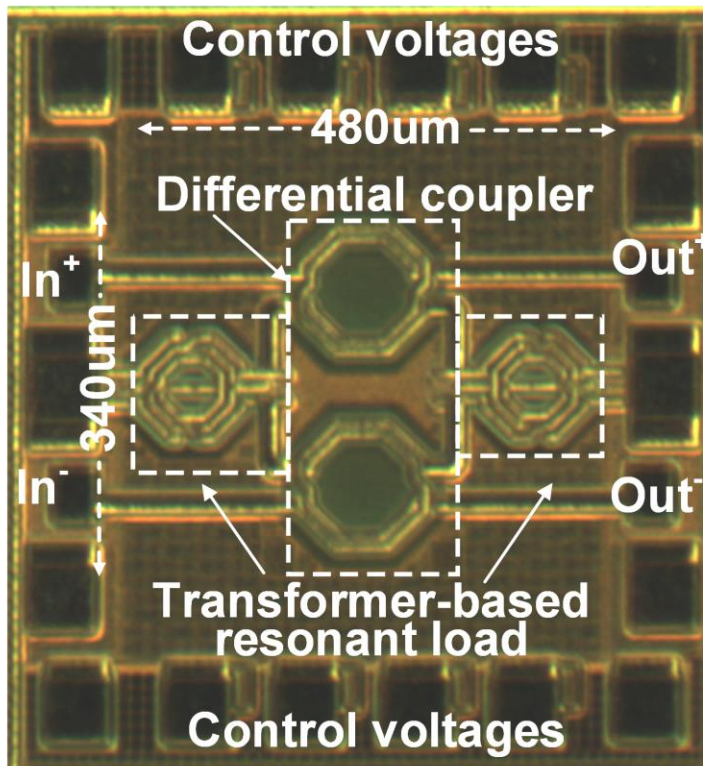
Transformer-based 90° coupler

- Standard 130nm SiGe BiCMOS process with a core area of 340μm×480μm
- Fully differential and symmetric layout

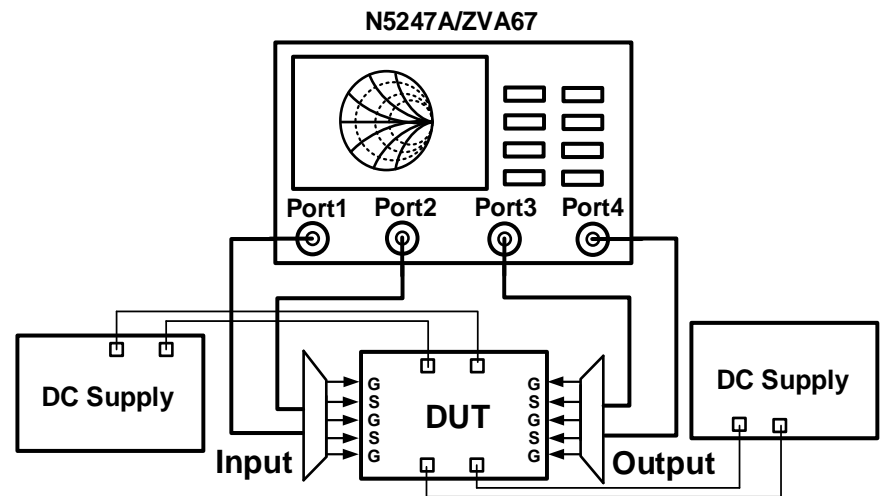
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- Chip microphotograph and test set-up

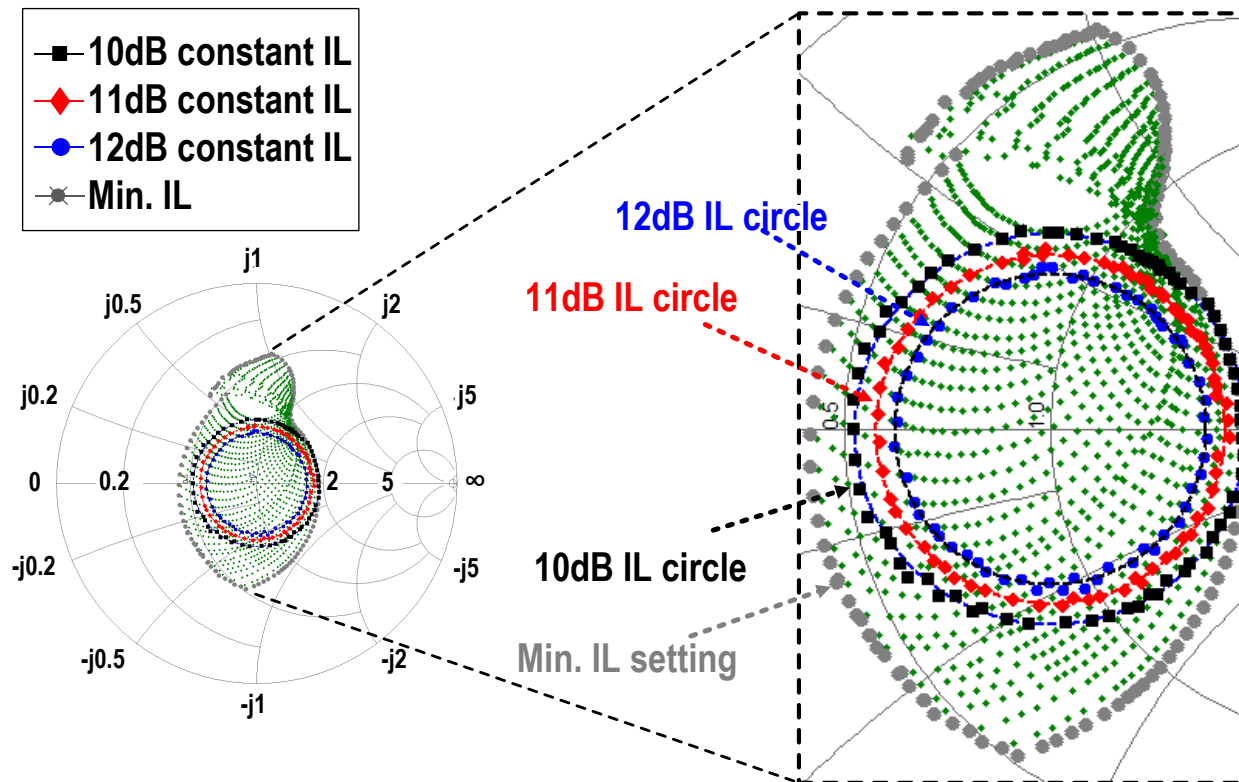


Fully symmetric layout



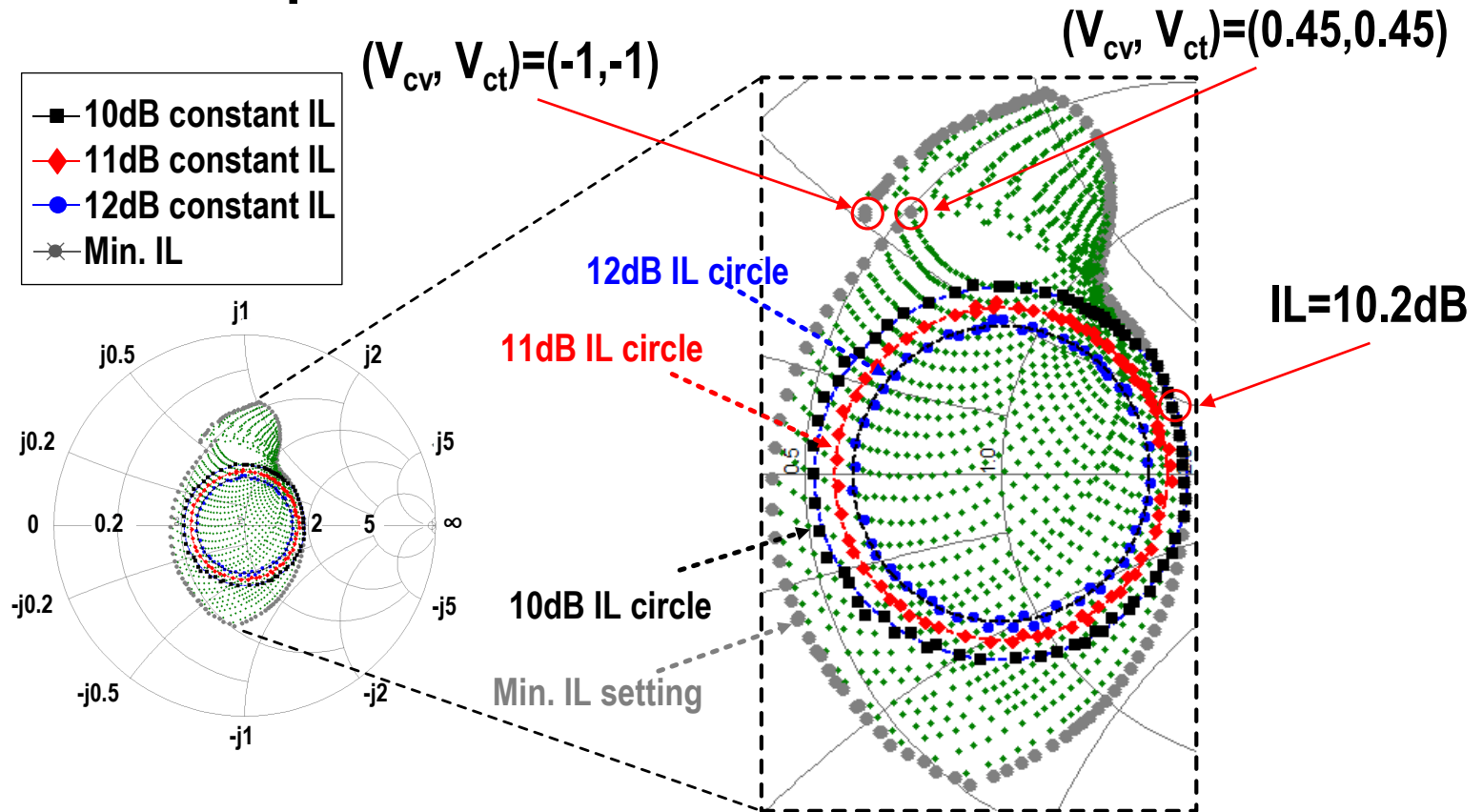
- Chips are tested by using probing
- A 4-port network analyzer for differential S-parameter measurement (Keysight and R&S)

- Measured complex insertion loss at 62GHz



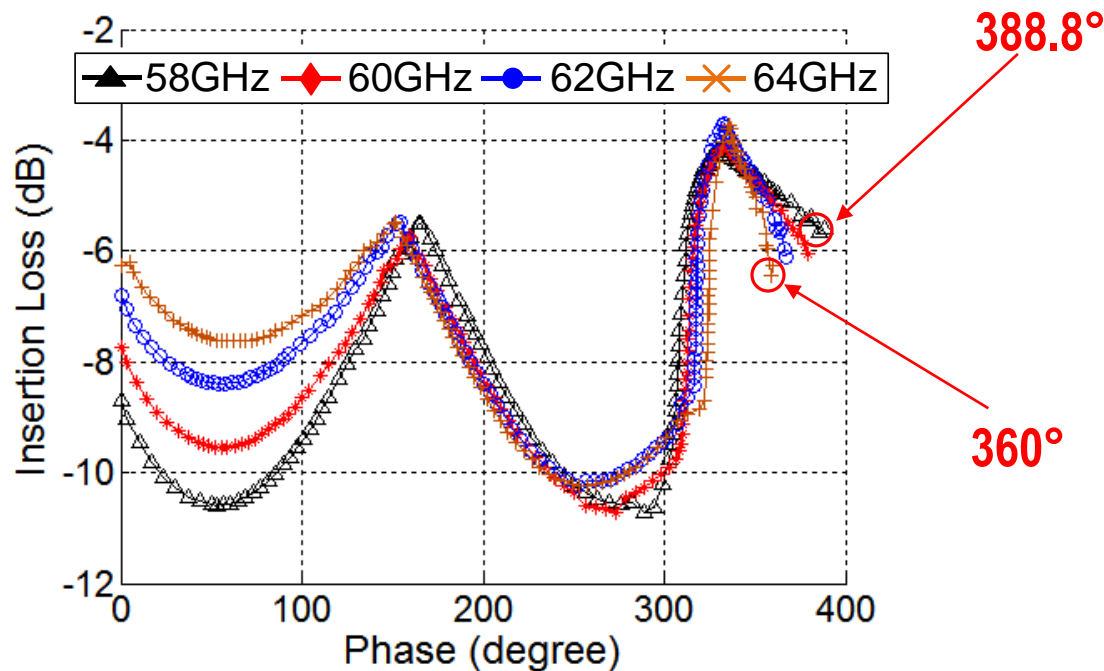
- Two control varactors \rightarrow 2D complex IL plot (phase and loss)
- Analog continuous tuning: discrete voltage step of 50mV

- Measured complex insertion loss at 62GHz



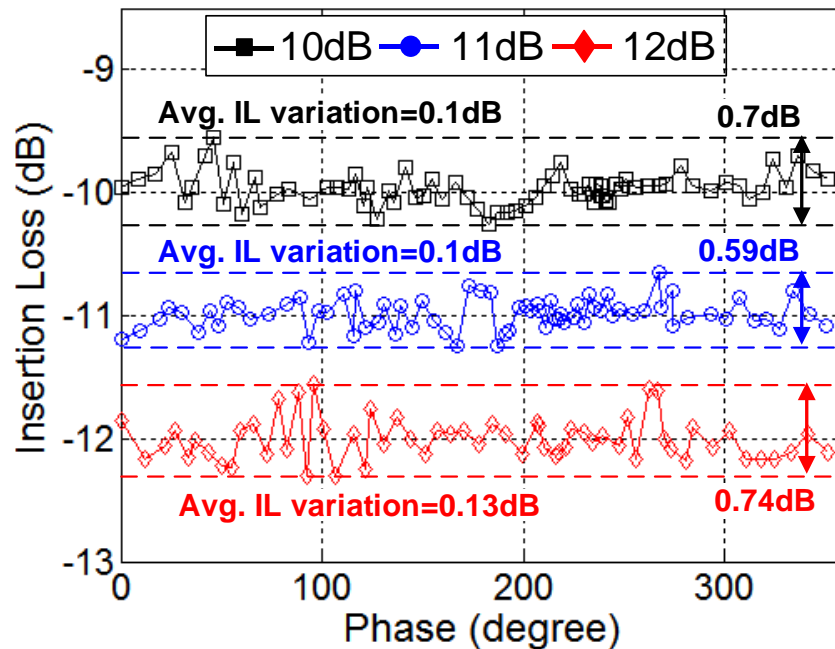
- Minimum IL contour covers phase shift = 367°
- Worst-case IL at minimum IL contour = 10.2dB

- Measured min. IL vs. phase shift for various frequencies



- BW=58GHz-64GHz under the condition ($IL < 11\text{dB}$ and phase shift $\geq 360^\circ$) with min. IL settings

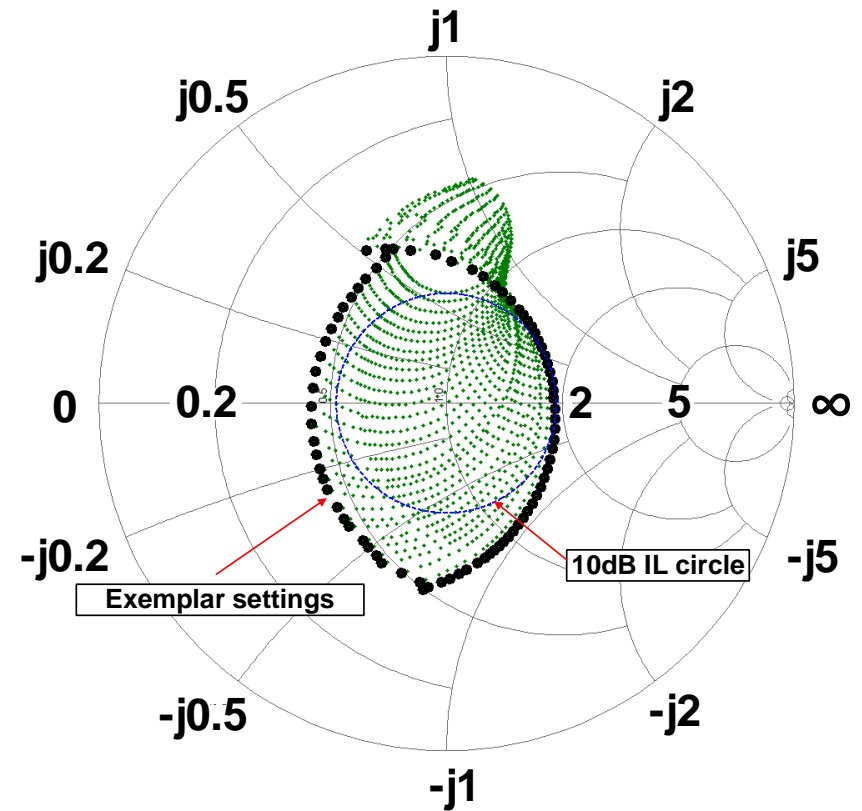
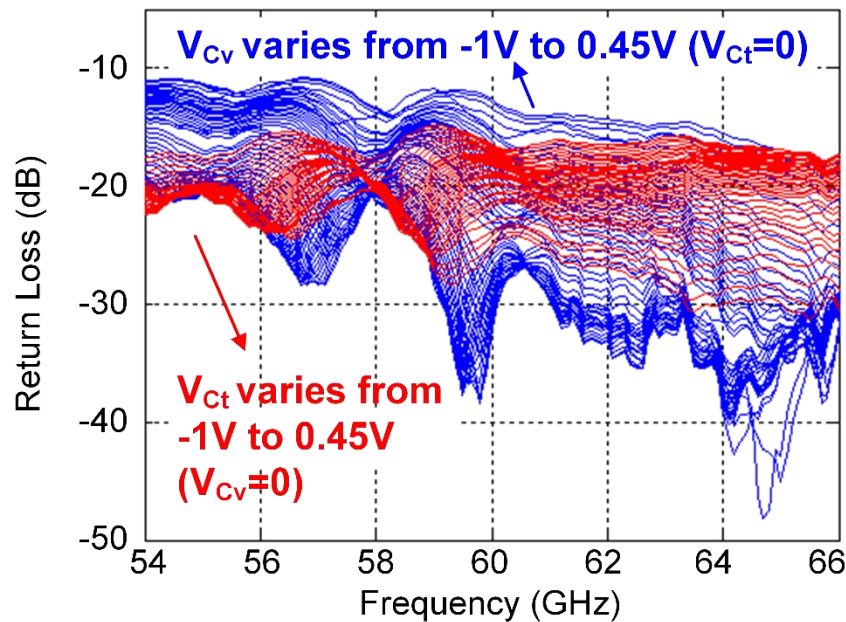
- Measured IL variation vs. phase shift for different constant IL circles at 62GHz



- IL variation:
 - 10dB circle: 0.7dB
 - 11dB circle: 0.59dB
 - 12dB circle: 0.74dB

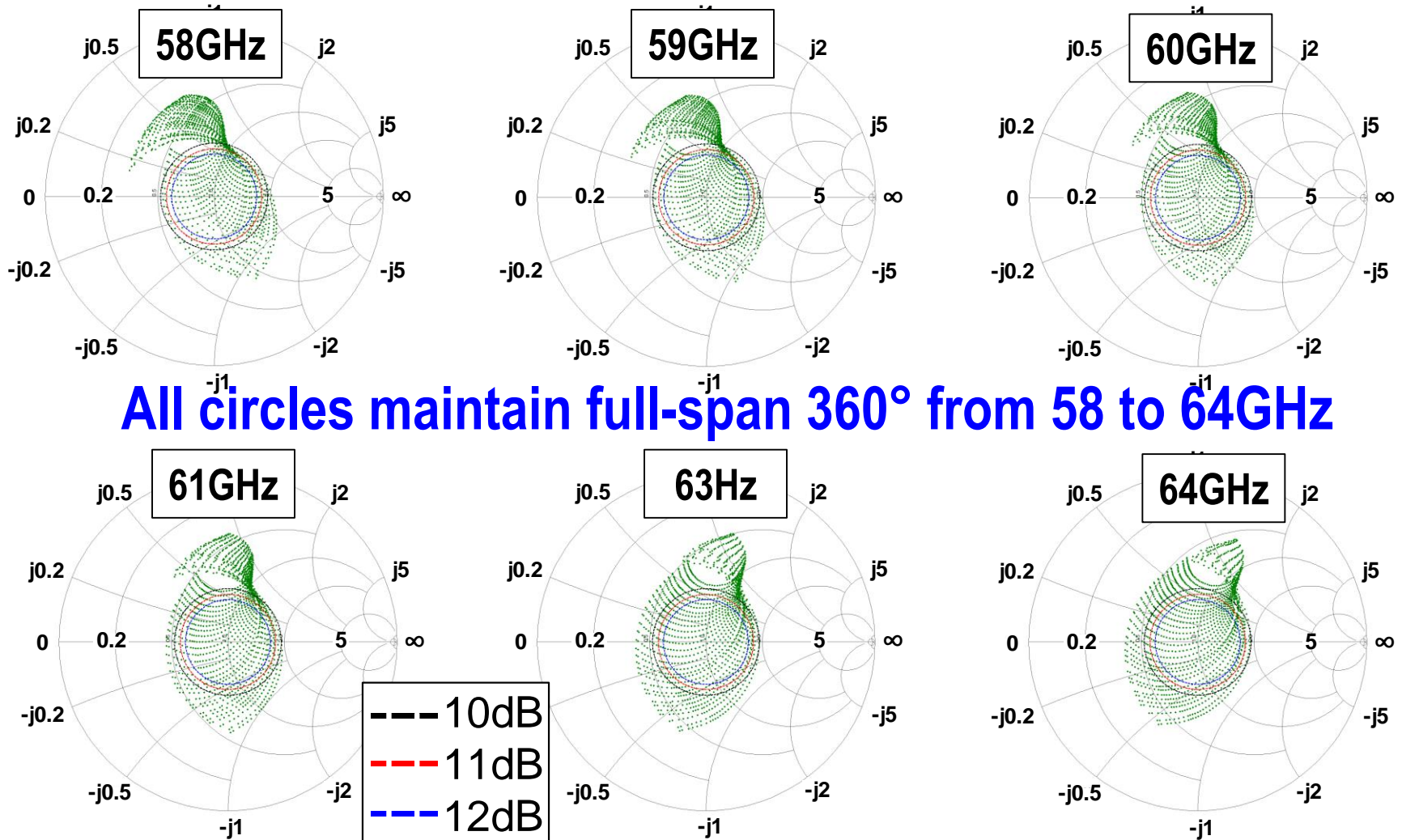
- IL variations are suppressed under constant IL circle settings

- Return loss (RL) of exemplar settings



– $RL > 11.2\text{dB}$ from 54GHz to 66GHz for exemplar settings 32

- Measured complex IL at various frequencies

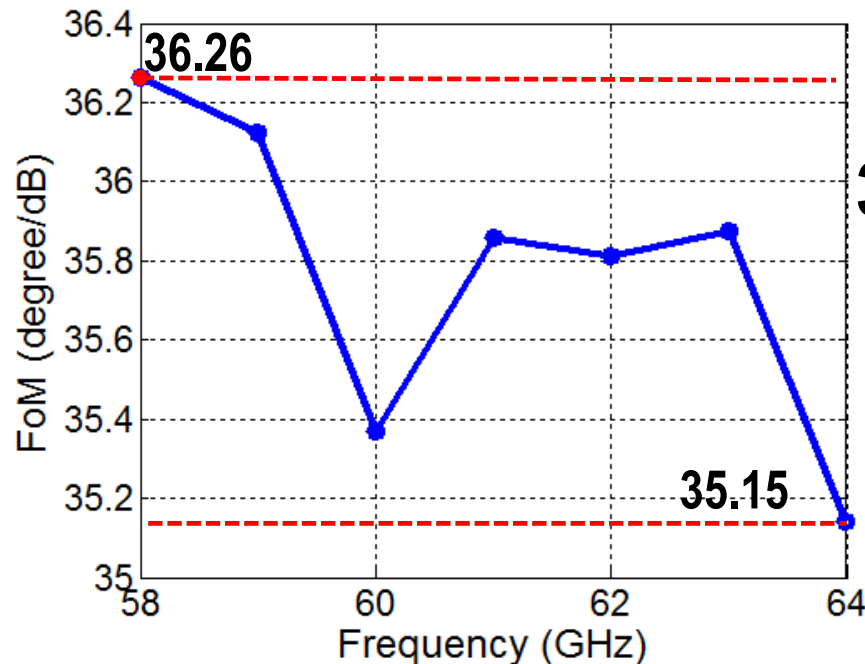


- **Figure-of-merit (FoM):**

- A quantitative metric to evaluate the performance of RTPS.

$$FoM(^{\circ}/dB) = \Delta\theta_{max} / IL_{max}$$

- Maximum phase shift $\Delta\theta_{max}$ divided by the worst-case IL.



$$35.15 \leq FoM \leq 36.26$$

- Comparison of fully integrated mm-Wave RTPS in silicon

Reference	This work	RFIC 09'	CICC 11'		ARRAY 10'	MWCL 13'
Frequency (GHz)	58-64	60	60		60	60
Max. phase shift (°)	367	180	180	147	156	90
Insertion Loss (dB)	3.7-10.2⁽¹⁾ 9.6-10.3⁽²⁾	4.2-7.5 (8.6-15) ⁽³⁾	5-8.3 (10-16.6) ⁽³⁾	3.3-5.7	4-6.2	4.5-6.9 (18-27.6) ⁽⁴⁾
Max. IL variation (dB)	6.5 0.7	3.3	3.3	2.4	2.2	1.4
Return Loss (dB)	>11.2	-	9	13	5	12
Best FoM (°/dB)	36.3	24	21.7	25.8	25	13
Chip area (mm ²)	0.16	0.18	0.031	0.048	0.33	0.25
Process	130nm BiCMOS	130nm BiCMOS	65nm CMOS		130nm BiCMOS	130nm BiCMOS

⁽¹⁾Min. IL settings; ⁽²⁾Constant 10dB IL circle settings; ⁽³⁾Two RTPS in cascade for 360°; ⁽⁴⁾Four RTPS in cascade for 360°.

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- The first mm-Wave full-span 360° fully differential integrated RTPS in silicon (BW: 58-64GHz).
- Our design performs low loss (10.2dB) and compact chip size ($340\mu\text{m} \times 480\mu\text{m}$).
- The IL variations are suppressed under the constant IL circle settings (10dB, 11dB and 12dB), only up to 0.74dB.
- The best FoM of $36.26^\circ/\text{dB}$ compared with other reported integrated mm-Wave RTPS in silicon.